

Search Notes



Application/Control No.

10/810,926

Examiner

Vuthe Siek

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	1,2,11,19-21	7/31/2006	VS
700	108,112	8/2/2006	VS
700	115	8/2/2006	VS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
see Interference search report printout		8/29/07	VS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST ALL DATABASES	7/31/2006	VS
UPDATED SEARCH EAST & IEEE	8/2/2006	VS
Updated search See printout	7/1/07	VS
updated see printout	8/29/07	VS